



1. Electrical Parameters

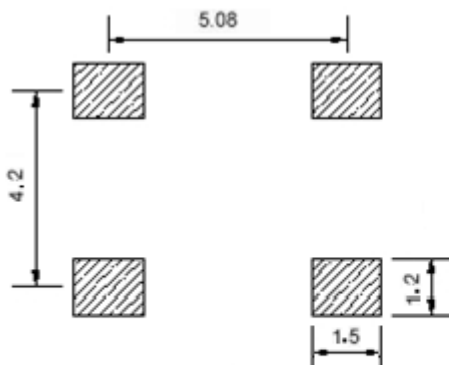
MODEL: T75B-0101-24.576MHz						
Item	Description	Parameters			Unit	Test Condition
		Min.	Typ.	Max.		
Output	Frequency	24.576			MHz	
	Output Waveform	HCMOS				
	Output Low Voltage			0.4	V	$V_{cc}=3.3V, O_{load}=15\text{ pF}$
	Output High Voltage	2.4			V	$V_{cc}=3.3V, O_{load}=15\text{ pF}$
	Duty Cycle	45	50	55	%	@50%
	Rise / Fall Time (10%~90%)			5	ns	@25°C
	Load	15			pF	
Frequency Stabilities	Frequency Tolerance vs. Operating Temperature Range	-0.28		+0.28	$\times 10^{-6}$	T_A varied from -20°C to 70°C, measurement referenced to frequency observed with $T_A = 25^\circ\text{C}, V_{cc}=3.3V, O_{load}=15\text{pF}$, temperature variable speed less than 2°C per minute.
	Initial Frequency Tolerance	-1		+1	$\times 10^{-6}$	Measurement referenced to frequency observed with $T_A=25^\circ\text{C}, V_{cc}=3.3V$ within 30 days after ex-works.
	Frequency Tolerance vs. Supply Voltage	-0.1		+0.1	$\times 10^{-6}$	measurement referenced to frequency observed $T_A=25^\circ\text{C}, V_{cc}$ varied from 3.13V to 3.47V, and $O_{Load}=15\text{pF}$.
	Frequency Tolerance vs. Load	-0.1		+0.1	$\times 10^{-6}$	5% load change measurement referenced to frequency observed with $T_A=25^\circ\text{C}, V_{cc}=3.3V, O_{Load}=15\text{pF}$.
	Aging Tolerance Per Day	-0.02		+0.02	$\times 10^{-6}$	$T_A=25^\circ\text{C}, V_{cc}=3.3V$, and after 1h of operation.
	Aging Tolerance 1 Year	-1		+1	$\times 10^{-6}$	
	Aging Tolerance 10 Years	-4.6		+4.6	$\times 10^{-6}$	
Power Supply	Current Consumption			10	mA	@25°C, $V_{cc}=3.3V, O_{Load}=15\text{pF}$.
	Supply Voltage	3.13	3.3	3.47	V	



Phase Noise	Phase Noise @25°C		-80	-75	dBc/Hz	10Hz
			-110	-105		100Hz
			-130	-125		1KHz
			-142	-137		10KHz
			-145	-140		100KHz
			-150	-145		1MHz
Environmental Conditions	Operable Temperature	-20		+70	°C	
	Storage Temperature	-55		+105	°C	
	ESD Level	Human Body Model,class2: 2000V to 4000V; ANSI/ESDA/JEDEC JS-001-2010.				
		Machine Model, class B: 200V to 400V; ANSI/ESDA/JEDEC JS-001-2010.				
	Moisture Sensitivity Level	Level 2.				
	Vibration	Test Condition: 0.75mm ;acceleration:10g;10Hz~2000Hz, one cycle per 30 min, test 2 hour. (3 times for each 3 directions X , Y , Z) .IEC 68-2-06 Test Fc.				
Shock	100g; 6ms; half sine wave (3 times for each 3 directions X , Y , Z),IEC 68-2-27 Test Ea/Severity 50A.					
Full Package Storage	Relative humidity (%)	20% ~70%				
	Temperature (°C)	-10~35°C				



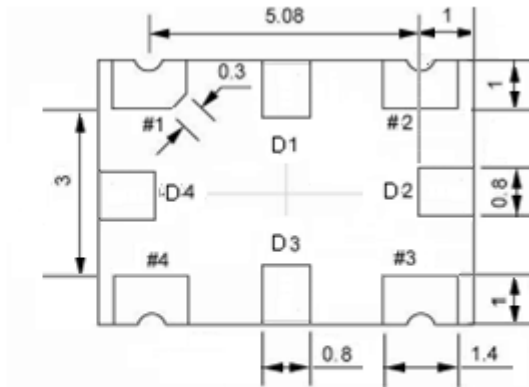
2. Mechanical Structure(mm)



Solder pad layout



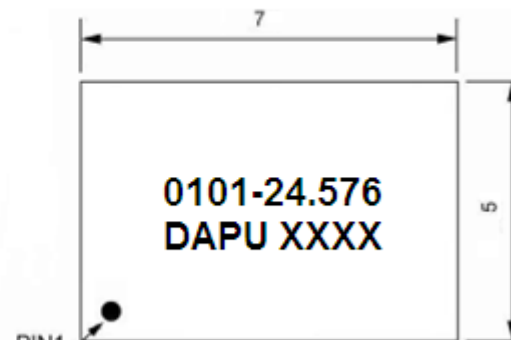
Right view



Bottom view



Side view



Top view

PIN FUNCTION

PIN	NOTATION	FUNCTION
D1, D2, D3, D4	NC	Not Connect
1	NC	Not Connect
2	GND	GND
3	OUTPUT	RF Output
4	VCC	Supply Voltage

Note1: Tolerance $\pm 0.2\text{mm}$ without mark

Note2: The first two xx representative: week

After two xx representative: year

Note3: Referential Weight 0.2g

Note4: NC is not connect



3. Test circuit



4. Reflow Soldering Curve (RoHS)



5. Package: Tape & Reel (mm)

